


<b>Search Notes</b> 	<b>Application/Control No.</b> 10797011	<b>Applicant(s)/Patent Under Reexamination</b> SAKAI ET AL.
	<b>Examiner</b> Radkiewicz, Jared W	<b>Art Unit</b> 2624

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Multiple keyword searches focused on inventor and assignee	7/24	JWR

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner